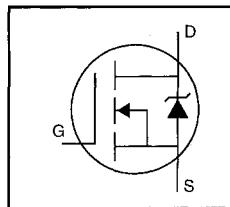


## HEXFET® Power MOSFET

- Dynamic dv/dt Rating
- Repetitive Avalanche Rated
- Isolated Central Mounting Hole
- Fast Switching
- Ease of Paralleling
- Simple Drive Requirements

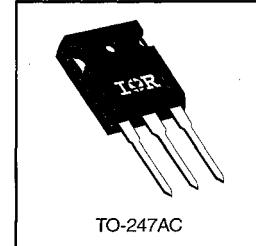


$V_{DSS} = 600V$   
 $R_{DS(on)} = 1.2\Omega$   
 $I_D = 6.8A$

### Description

Third Generation HEXFETs from International Rectifier provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-247 package is preferred for commercial-industrial applications where higher power levels preclude the use of TO-220 devices. The TO-247 is similar but superior to the earlier TO-218 package because of its isolated mounting hole. It also provides greater creepage distance between pins to meet the requirements of most safety specifications.



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### Absolute Maximum Ratings

	Parameter	Max.	Units
$I_D @ T_c = 25^\circ C$	Continuous Drain Current, $V_{GS} @ 10 V$	6.8	
$I_D @ T_c = 100^\circ C$	Continuous Drain Current, $V_{GS} @ 10 V$	4.3	A
$I_{DM}$	Pulsed Drain Current ①	27	
$P_D @ T_c = 25^\circ C$	Power Dissipation	150	W
	Linear Derating Factor	1.2	W/ $^\circ C$
$V_{GS}$	Gate-to-Source Voltage	$\pm 20$	V
$E_{AS}$	Single Pulse Avalanche Energy ②	410	mJ
$I_{AR}$	Avalanche Current ①	6.8	A
$E_{AR}$	Repetitive Avalanche Energy ①	15	mJ
$dv/dt$	Peak Diode Recovery $dv/dt$ ③	3.0	V/ns
$T_J$ $T_{STG}$	Operating Junction and Storage Temperature Range	-55 to +150	$^\circ C$
	Soldering Temperature, for 10 seconds	300 (1.6mm from case)	
	Mounting Torque, 6-32 or M3 screw	10 lbf•in (1.1 N•m)	

### Thermal Resistance

	Parameter	Min.	Typ.	Max.	Units
$R_{JC}$	Junction-to-Case	—	—	0.83	
$R_{CS}$	Case-to-Sink, Flat, Greased Surface	—	0.24	—	$^\circ C/W$
$R_{JA}$	Junction-to-Ambient	—	—	40	

Electrical Characteristics @  $T_J = 25^\circ\text{C}$  (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Test Conditions
$V_{(\text{BR})\text{DSS}}$	Drain-to-Source Breakdown Voltage	600	—	—	V	$V_{GS}=0\text{V}$ , $I_D = 250\mu\text{A}$
$\Delta V_{(\text{BR})\text{DSS}/\Delta T_J}$	Breakdown Voltage Temp. Coefficient	—	0.70	—	$\text{V}/^\circ\text{C}$	Reference to $25^\circ\text{C}$ , $I_D = 1\text{mA}$
$R_{DS(on)}$	Static Drain-to-Source On-Resistance	—	—	1.2	$\Omega$	$V_{GS}=10\text{V}$ , $I_D=4.1\text{A}$ ④
$V_{GS(\text{th})}$	Gate Threshold Voltage	2.0	—	4.0	V	$V_{DS}=V_{GS}$ , $I_D = 250\mu\text{A}$
$g_{fs}$	Forward Transconductance	4.9	—	—	S	$V_{DS}=100\text{V}$ , $I_D = 4.1\text{A}$ ④
$I_{DSS}$	Drain-to-Source Leakage Current	—	—	100	$\mu\text{A}$	$V_{DS}=600\text{V}$ , $V_{GS}=0\text{V}$
		—	—	500	$\mu\text{A}$	$V_{DS}=480\text{V}$ , $V_{GS}=0\text{V}$ , $T_J=125^\circ\text{C}$
$I_{GSS}$	Gate-to-Source Forward Leakage	—	—	100	nA	$V_{GS}=20\text{V}$
	Gate-to-Source Reverse Leakage	—	—	-100		$V_{GS}=-20\text{V}$
$Q_g$	Total Gate Charge	—	—	60	nC	$I_D=6.2\text{A}$
$Q_{gs}$	Gate-to-Source Charge	—	—	8.3		$V_{DS}=360\text{V}$
$Q_{gd}$	Gate-to-Drain ("Miller") Charge	—	—	30		$V_{GS}=10\text{V}$ See Fig. 6 and 13 ④
$t_{d(on)}$	Turn-On Delay Time	—	13	—	ns	$V_{DD}=300\text{V}$
$t_r$	Rise Time	—	18	—		$I_D=6.2\text{A}$
$t_{d(off)}$	Turn-Off Delay Time	—	55	—		$R_G=9.1\Omega$
$t_f$	Fall Time	—	20	—		$R_D=47\Omega$ See Figure 10 ④
$L_D$	Internal Drain Inductance	—	5.0	—	nH	Between lead, 6 mm (0.25in.) from package and center of die contact
$L_S$	Internal Source Inductance	—	13	—		
$C_{iss}$	Input Capacitance	—	1300	—	pF	$V_{GS}=0\text{V}$
$C_{oss}$	Output Capacitance	—	160	—		$V_{DS}=25\text{V}$
$C_{rss}$	Reverse Transfer Capacitance	—	30	—		$f=1.0\text{MHz}$ See Figure 5

## Source-Drain Ratings and Characteristics

	Parameter	Min.	Typ.	Max.	Units	Test Conditions
$I_S$	Continuous Source Current (Body Diode)	—	—	6.8	A	MOSFET symbol showing the integral reverse p-n junction diode.
$I_{SM}$	Pulsed Source Current (Body Diode) ①	—	—	27		
$V_{SD}$	Diode Forward Voltage	—	—	1.5	V	$T_J=25^\circ\text{C}$ , $I_S=6.8\text{A}$ , $V_{GS}=0\text{V}$ ④
$t_{rr}$	Reverse Recovery Time	—	450	940	ns	$T_J=25^\circ\text{C}$ , $I_F=6.2\text{A}$
$Q_{rr}$	Reverse Recovery Charge	—	3.8	7.9	$\mu\text{C}$	$dI/dt=100\text{A}/\mu\text{s}$ ④
$t_{on}$	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by $L_S+L_D$ )				

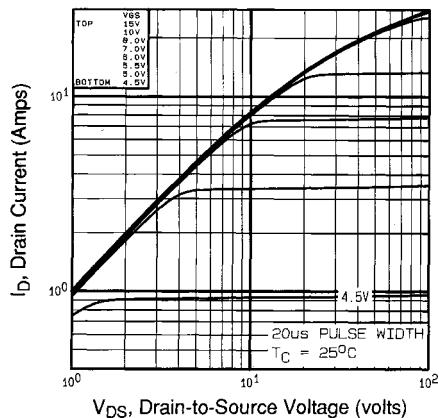
## Notes:

① Repetitive rating; pulse width limited by max. junction temperature (See Figure 11)

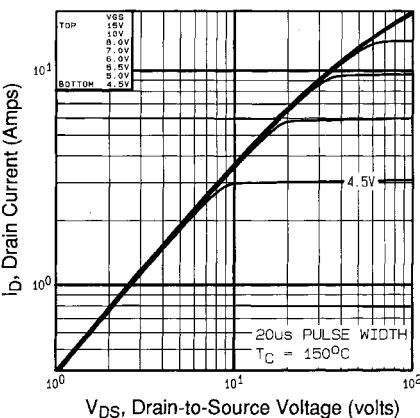
③  $I_{SD}\leq 6.8\text{A}$ ,  $di/dt\leq 80\text{A}/\mu\text{s}$ ,  $V_{DD}\leq V_{(\text{BR})\text{DSS}}$ ,  $T_J\leq 150^\circ\text{C}$

②  $V_{DD}=50\text{V}$ , starting  $T_J=25^\circ\text{C}$ ,  $L=16\text{mH}$   $R_G=25\Omega$ ,  $I_{AS}=6.8\text{A}$  (See Figure 12)

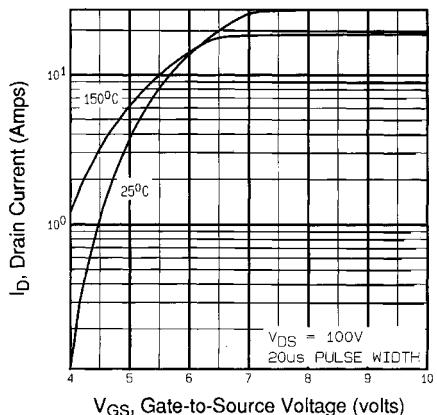
④ Pulse width  $\leq 300\ \mu\text{s}$ ; duty cycle  $\leq 2\%$ .



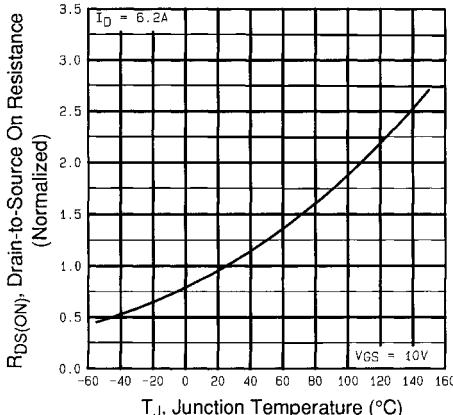
**Fig 1.** Typical Output Characteristics,  
 $T_C=25^\circ\text{C}$



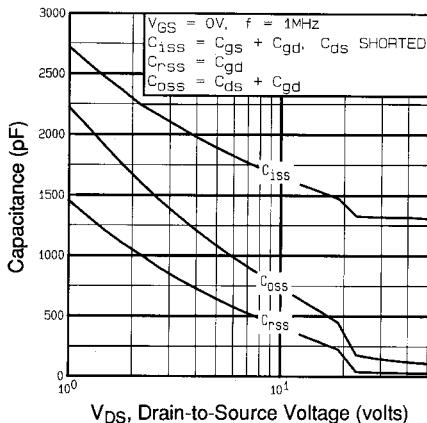
**Fig 2.** Typical Output Characteristics,  
 $T_C=150^\circ\text{C}$



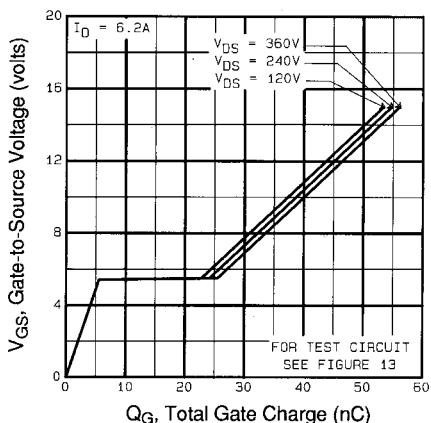
**Fig 3.** Typical Transfer Characteristics



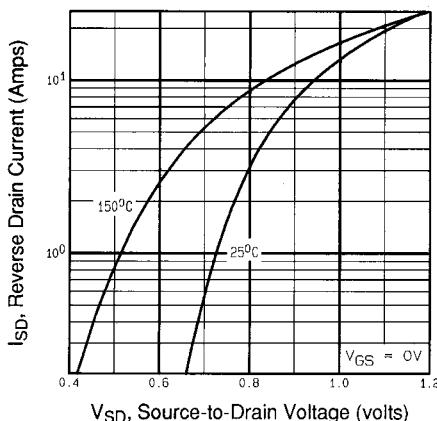
**Fig 4.** Normalized On-Resistance  
Vs. Temperature



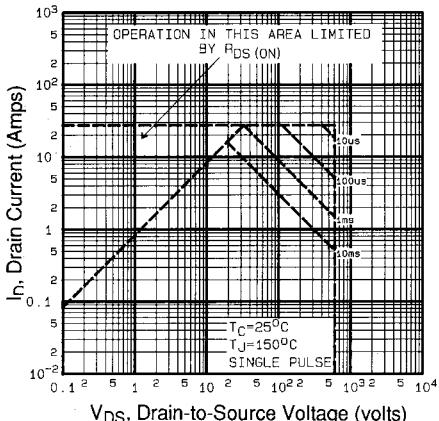
**Fig 5.** Typical Capacitance Vs.  
Drain-to-Source Voltage



**Fig 6.** Typical Gate Charge Vs.  
Gate-to-Source Voltage



**Fig 7.** Typical Source-Drain Diode  
Forward Voltage



**Fig 8.** Maximum Safe Operating Area

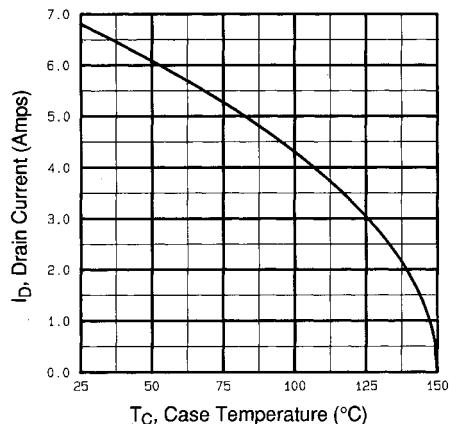


Fig 9. Maximum Drain Current Vs. Case Temperature

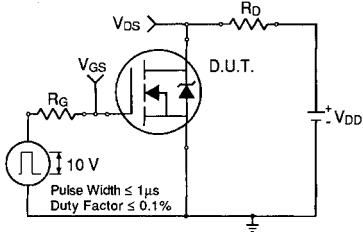
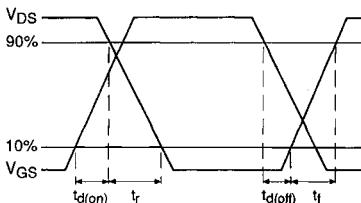


Fig 10a. Switching Time Test Circuit



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Fig 10b. Switching Time Waveforms

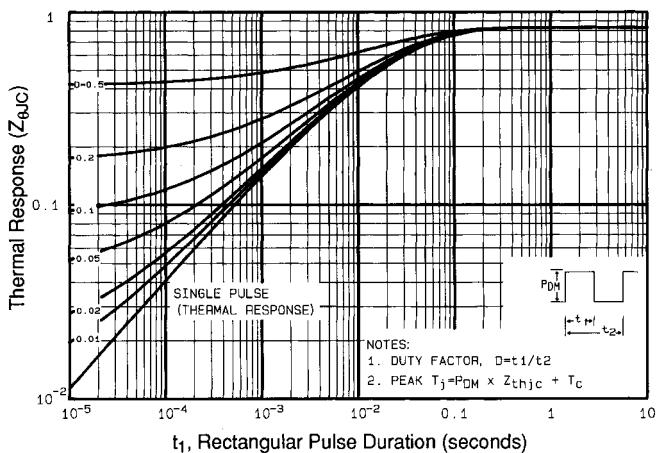
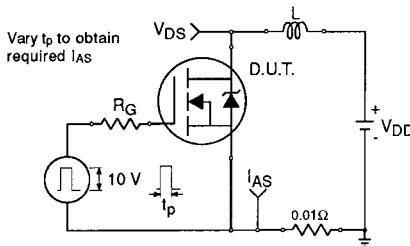
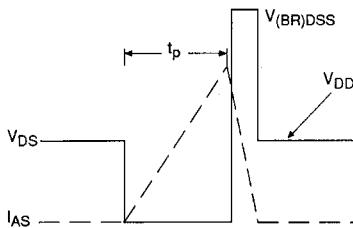


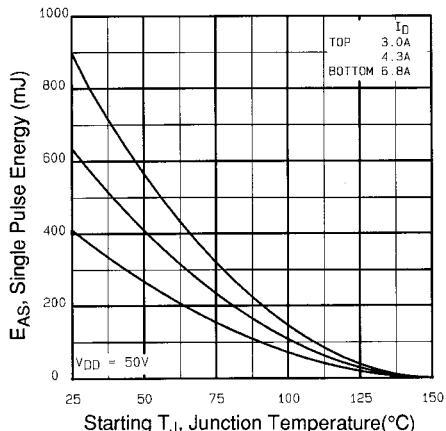
Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case



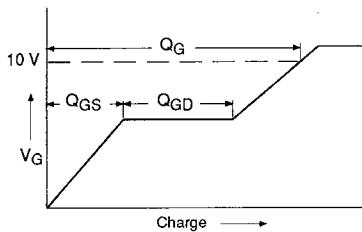
**Fig 12a.** Unclamped Inductive Test Circuit



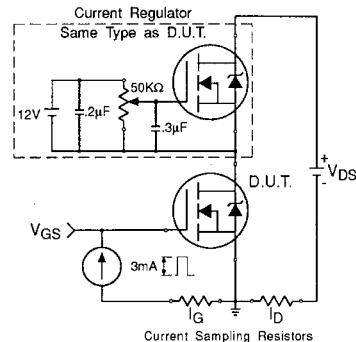
**Fig 12b.** Unclamped Inductive Waveforms



**Fig 12c.** Maximum Avalanche Energy Vs. Drain Current



**Fig 13a.** Basic Gate Charge Waveform



**Fig 13b.** Gate Charge Test Circuit

**Appendix A:** Figure 14, Peak Diode Recovery dv/dt Test Circuit – See page 1505

**Appendix B:** Package Outline Mechanical Drawing – See page 1511

**Appendix C:** Part Marking Information – See page 1517